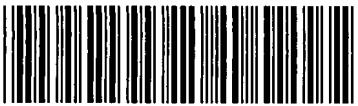


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10813649	SRIVASTAVA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Hajnik, Daniel F	2628

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Classes 345/423,418,419,420,428,581,619, and 441 are combined with text search;	8/3/07	DFH
NPL Search conducted in ACM, Google, and IEEE, search terms include fractals, and L P norm	8/3/07	DFH
Presented claim 2 in QEM	8/9/07	DFH
Talked to SPE Kee Tung	8/9/07	DFH
EAST text search (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB -- see search history printout)	8/14/07	DFH

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
	Interference Search History attached	8/16/07	DFH